

Search Notes

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Examiner

JOHN J. LEE

Applicant(s)/Patent under
Reexamination

KIKKOJI ET AL.

Art Unit

2618

SEARCHED

Class	Subclass	Date	Examiner
455	3.01,3.03 3.04,415 414.1,411	6/2/2008	J.L
455	414.3	6/2/2008	J.L
455	456.3	6/2/2008	J.L
455	179.1	6/2/2008	J.L

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	6/2/2008	J.L